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James G. Grote
François Kajzar
Mikael Lindgren
Editors

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Contents

v *Conference Committee*

SESSION 1 ORGANIC NONLINEAR OPTICAL MATERIALS I

- 7118 02 **Overview of innovative next generation materials for security and defense applications (Invited Paper)** [7118-01]
E. W. Taylor, L. R. Taylor, International Photonics Consultants (United States)
- 7118 03 **New organic nonlinear optical materials and their integration into silicon nanophotonic circuits and devices (Invited Paper)** [7118-02]
L. R. Dalton, Univ. of Washington (United States)

SESSION 2 ORGANIC NONLINEAR OPTICAL MATERIALS II

- 7118 09 **Calibration and rotational contribution in third-order NLO properties characterization** [7118-07]
I. Rau, Politehnica Univ. of Bucharest (Romania); F. Kajzar, J. Luc, B. Sahraoui, G. Boudebs, Univ. of Angers (France)

SESSION 3 ORGANIC BASED MATERIALS AND DEVICES I

- 7118 0C **OLET architectures for electrically-pumped organic lasers (Invited Paper)** [7118-10]
R. Zamboni, R. Capelli, S. Toffanin, M. Murgia, CNR-Istituto per lo Studio dei Materiali Nanostrutturati (Italy); M. Först, RWTH Aachen Universität Institut für Halbleitertechnik (Germany); M. Muccini, CNR-Istituto per lo Studio dei Materiali Nanostrutturati (Italy)

SESSION 4 ORGANIC BASED MATERIALS AND DEVICES II

- 7118 0F **Holographic security media prepared from photochromic fluorescent films (Invited Paper)** [7118-13]
J. Kim, E. Kim, Yonsei Univ. (South Korea)

SESSION 5 BIOTECHNOLOGY I

- 7118 0H **Material requirements for bio-inspired sensing systems (Invited Paper)** [7118-15]
P. Biggins, P. Lloyd, D. Salmond, Defence Science and Technology Lab. (United Kingdom); A. Kusterbeck, Naval Research Lab. (United States)

- 7118 0J **Optical properties of DNA-CTMA and PA-CTMA doped with (E)-2-(2-(4-(diethylamino)styryl)-4H-pyran-4-ylidene)malononitrile (DCM) (Invited Paper)** [7118-17]
D. H. Choi, J. E. Lee, Y.-W. Kwon, U. R. Lee, M. J. Cho, K. H. Kim, J.-I. Jin, Korea Univ. (Republic of Korea)

SESSION 6 BIOTECHNOLOGY II

- 7118 0L **Biopolymer-based gate dielectric for organic field effect transistors (Invited Paper)** [7118-19]
K. R. Sarma, S. Dodd, C. Chanley, J. Roush, Honeywell International (United States); N. S. Sariciftci, Johannes Kepler Univ. (Austria); R. R. Naik, J. G. Grote, Air Force Research Lab. (United States)
- 7118 0M **Semiconductive properties of DNA-based materials** [7118-20]
F. Ouchen, S. Kim, Air Force Research Lab. (United States); G. Subramanyam, P. Yanney, L. Dai, Univ. of Dayton (United States); R. Naik, J. Grote, Air Force Research Lab. (United States)

Author Index

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Session Chairs

- 1 Organic Nonlinear Optical Materials I
James G. Grote, Air Force Research Laboratory (United States)
- 2 Organic Nonlinear Optical Materials II
Edward W. Taylor, International Photonics Consultants, Inc. (United States)
- 3 Organic Based Materials and Devices I
James G. Grote, Air Force Research Laboratory (United States)
- 4 Organic Based Materials and Devices II
Chantal Andraud, École Normale Supérieure de Lyon (France)
- 5 Biotechnology I
James G. Grote, Air Force Research Laboratory (United States)
- 6 Biotechnology II
Peter Biggins, Defence Science and Technology Laboratory (United Kingdom)